

SM8005DSK-TRG-VB Datasheet N-Channel 80 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)	
80	0.062 at V _{GS} = 10 V	3.5	7.3 nC	
80			7.5110	

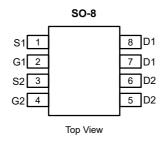
FEATURES

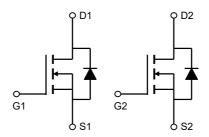
- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- 100 % $\rm R_{\rm g}$ and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



APPLICATIONS

- DC/DC Conversion
 - Notebook System Power





Absolute Maximum Ratings T _A =25℃ unless otherwise noted					
Parameter		Symbol	Maximum	Units	
Drain-Source Voltage)	V_{DS}	80	V	
Gate-Source Voltage		V_{GS}	±30	V	
Continuous Drain Current	T _A =25℃		3.5		
	T _A =70℃	ID	2.9	Α	
Pulsed Drain Current ^C		I _{DM}	18		
Avalanche Current ^C		I _{AR}	16	A	
Repetitive avalanche energy L=0.1mH ^C		E _{AR}	12.8	mJ	
Power Dissipation ^B	T _A =25℃	В	2	W	
	T _A =70℃	P _D 1.3	1.3	T vv	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	С	

Thermal Characteristics					
Parameter	Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	D	48	62.5	℃/W
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	74	90	℃/W
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	32	40	℃/W



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC F	STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V	80			V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =80V, V _{GS} =0V			1	μΑ	
D33	<u> </u>	T _J =55℃			5	ρ	
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±30V			100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	3.5	4.2	5	V	
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V	18			Α	
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =3.5A		62		mΩ	
D3(ON)		T _J =125℃		113.0			
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =3.5A		15		S	
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.77	1	V	
I_S	Maximum Body-Diode Continuous Cur	rent			2.5	Α	
I _{SM}	Pulsed Body-diode Current ^C				18	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance		510	640	770	pF	
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =40V, f=1MHz	28	40	52	pF	
C _{rss}	Reverse Transfer Capacitance		12	20	30	pF	
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz	0.9	1.8	2.7	Ω	
SWITCHI	SWITCHING PARAMETERS						
Q _g (10V)	Total Gate Charge		8	11	13	nC	
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =40V, I _D =3.5A	4	5.5	7		
Q_{gs}	Gate Source Charge	V _{GS} -10V, V _{DS} -40V, I _D -3.3A	4	5	6	nC	
Q_{gd}	Gate Drain Charge	1	0.7	1.2	1.7	nC	
t _{D(on)}	Turn-On DelayTime			7.2		ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =40V, R_L =8 Ω ,		2.2		ns	
$t_{D(off)}$	Turn-Off DelayTime	R_{GEN} =3 Ω		17		ns	
t _f	Turn-Off Fall Time	7		2		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =3.5A, dI/dt=300A/μs	14	20	26	ns	
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =3.5A, dI/dt=300A/μs	35	50	65	nC	

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using \leq 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150$ °C. Ratings are based on low frequency and duty cycles to keep initial $T_J=25$ °C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

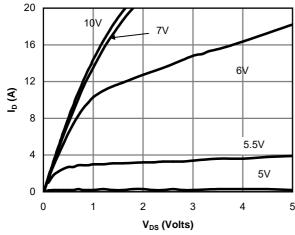


Fig 1: On-Region Characteristics (Note E)

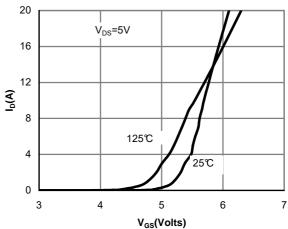


Figure 2: Transfer Characteristics (Note E)

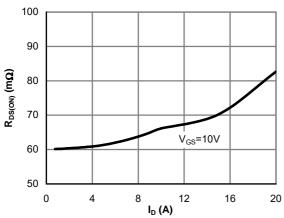
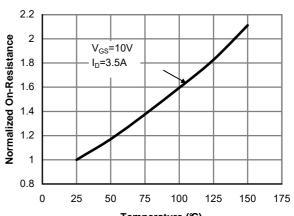


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (℃)
Figure 4: On-Resistance vs. Junction
Temperature (Note E)

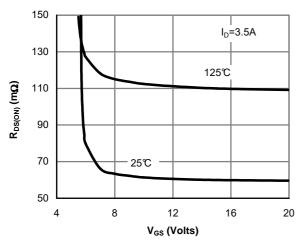


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

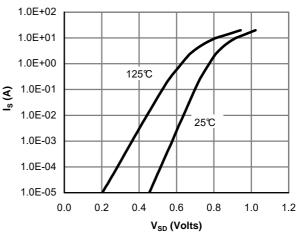


Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

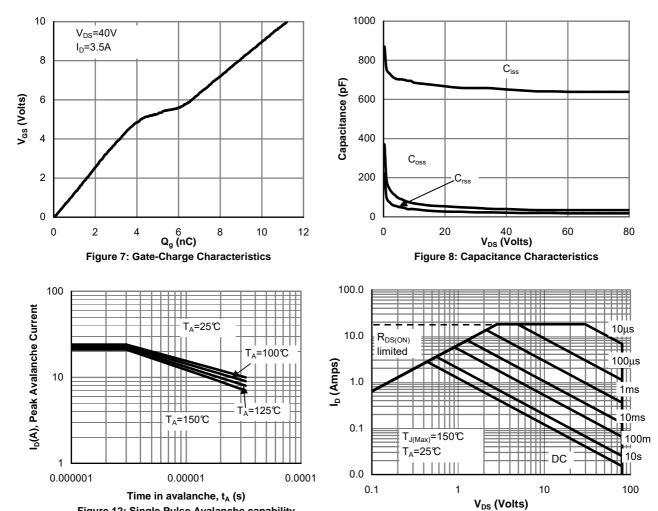


Figure 12: Single Pulse Avalanche capability

4

Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

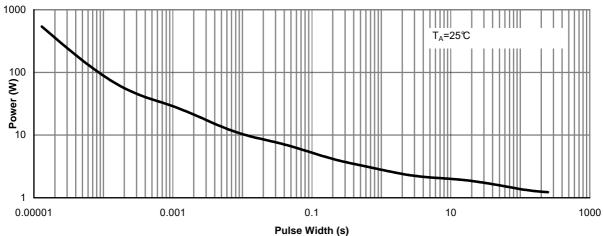


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

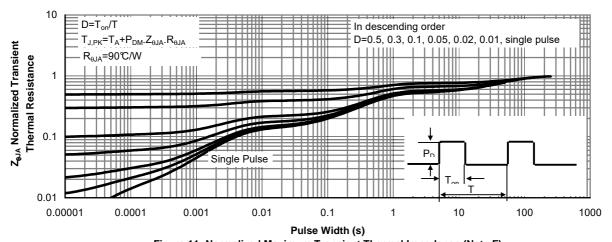
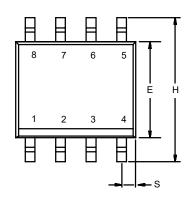
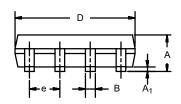


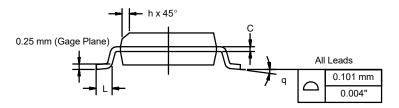
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



SOIC (NARROW): 8-LEADJEDEC Part Number: MS-012







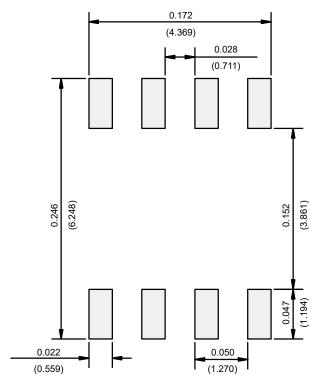
	MILLIMETERS		INC	HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
FCN: C-06527-Rev 11-Sen-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

Return to Index



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